CLAIMS:

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- 2 1. A system for sensing and recording or transmitting processing conditions
- 3 comprising:
- a substrate having a surface, the substrate comprising sensors to measure the
- 5 processing conditions of the substrate at different areas of the substrate; and
- one or more electronics platforms mounted to the surface of the substrate
- 7 comprising signal acquisition circuitry coupled to an output of the sensors.
- 1 2. The system of claim 1 wherein each of the one or more platforms
- 2 comprise one or more legs and a shelf, the one or more legs elevating the shelf from the
- 3 surface.
- 1 3. The system of claim 2 wherein the signal acquisition circuitry is upon the
- 2 shelf.
- 1 4. The system of claim 1 wherein the substrate is a wafer.
- 1 5. The system of claim 1 wherein the substrate comprises glass.
- 1 6. The system of claim 1 further comprising a remote data processing
- 2 module.
- The system of claim 2 wherein the electronics platform further comprises
- 4 data transmission circuitry comprising a transceiver, the data transmission circuitry
- 5 operable to transmit the processing conditions in real time during measurement of the
- 6 processing conditions to the data processing module via the transceiver.

- 2 signals.
- 1 9. The system of claim 7 wherein the transceiver transmits and receives IR
- 2 signals.
- 1 10. The system of claim 7 wherein the transceiver inductively transmits and
- 2 receives.
- 1 11. The system of claim 7 wherein the transceiver sonically transmits and
- 2 receives.

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- 1 12. The system of claim 7 wherein the system further comprises a data
- 2 transmission cable and wherein the data transmission circuitry transmits the processing
- 3 conditions over the cable.
- 1 13. The system of claim 7 wherein the data transmission circuitry is further
- 2 operable to send and receive control signals to and from the data processing module.
- 1 14. The system of claim 6 wherein the data processing module comprises a
- 2 microprocessor, a storage device, a display, and an input device.
- 1 15. The system of claim 1 wherein the processing conditions measured by the
- 2 sensors comprise one or more of the following conditions: temperature, pressure, flow
- 3 rate, vibration, ion current density, ion current energy, and light energy density.
- 4 16. The system of claim 1 wherein the sensors are discrete sensors mounted in
- 5 or on the wafer.

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- 2 formed in or on the wafer.
- 1 18. The system of claim 1 wherein the electronics platform further comprises 2 a power supply.
- 1 19. The system of claim 17 wherein the power supply comprises an inductive 2 power source.
- 1 20. The system of claim 1 further comprising an antenna connected to the wafer and electrically coupled to the signal acquisition circuitry.
- 1 21. A process condition monitoring device comprising:
- 2 a substrate having a first perimeter, the substrate comprising sensors to measure
- 3 the processing conditions of the substrate at different areas of the substrate; and
- an electronics module having a second perimeter, the module comprising:
- 5 signal acquisition circuitry coupled to an output of the sensors;
- data transmission circuitry coupled to the signal acquisition circuitry;
- 7 a power source; and
- 8 leads connecting the substrate to the electronics module for transmitting signals
- 9 between the substrate and the electronics module.

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- 1 22. The monitoring device of claim 21 wherein the signal acquisition circuitry
- 2 is configured to amplify an output signal of the sensors.

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- 1 23. The monitoring device of claim 21 wherein the data transmission circuitry
- 2 comprises a micro-controller and is configured to correct the output signal using sensor
- 3 calibration coefficients.
- 1 24. The monitoring device of claim 22 wherein the signal acquisition circuitry
- 2 is further configured to provide an input signal to the sensors.
- 1 25. The monitoring device of claim 24 wherein the input signal comprises
- 2 input power.
- 1 26. The monitoring device of claim 21 further comprising a remote data
- 2 processing system, and wherein the data transmission circuitry comprises a wireless
- 3 transceiver to transmit the processing conditions to the remote system.
- 1 27. The monitoring device of claim 22 wherein the data transmission circuitry
- 2 comprises an analog to digital converter.
- 1 28. The monitoring device of claim 21 wherein the data transmission circuitry
- 2 comprises memory, and wherein the data transmission circuitry stores processing
- 3 conditions in the memory.
- 1 29. The monitoring device of claim 26 wherein the remote system is
- 2 configured to adjust the output signal using calibration coefficients.
- 1 30. The monitoring device of claim 21 wherein the transceiver transmits and
- 2 receives RF signals.
- 1 31. The monitoring device of claim 21 wherein the transceiver transmits and
- 2 receives IR signals.

- The monitoring device of claim 21 wherein the transceiver transmits and 32.
- 2 receives sonic signals.
- The monitoring device of claim 21 wherein the data transmission circuitry 1 33.
- 2 comprises one or more connectors to couple a remote system to the device with a
- 3 communications cable.
- 1 34. The monitoring device of claim 26 wherein the remote system is a
- 2 microprocessor controlled device.
- The monitoring device of claim 21 wherein the processing conditions 1 .35.
- 2 measured by the sensors comprise one or more of the following conditions: temperature,
- 3 pressure, flow rate, vibration, ion current density, ion current energy, and light energy
- 4 density.
- The monitoring device of claim 21 wherein the flexible cable is a ribbon 1 36.
- 2 cable.
- 1 37. A device for monitoring processing conditions to be inserted by a robot
- 2 hand into a sealed chamber, the device comprising:
- 3 a first member comprising sensors;
- a second member comprising electronics; 4
- 5 a conductive cable or conductors connecting the first and second members,
- wherein the first and second members fit into or onto a robot hand or hands, and 6
- 7 wherein the device can be extended to a second position by the robot hand such
- 8 that the first member is inside the sealed chamber and the second circular member is





- 9 outside the chamber, thereby not subjecting the electronics of the second member to the
- 10 conditions within the chamber.
- 1 38. The device of claim 37 wherein in the second position the cable of the
- device is sealed at a door of the chamber.
- 1 39. The device of claim 37 wherein the electronics comprise a power supply,
- 2 and an amplifier.
- 1 40. The device of claim 39 wherein the electronics further comprise a
- 2 transceiver for communicating to a data processing device.
- 1 41. The device of claim 39 wherein the electronics further comprise an
- 2 analog-to-digital converter.
- 1 42. The device of claim 37 wherein the device further comprises a data
- 2 processing computer coupled to the second circular member.
- 1 43. The device of claim 37 wherein the first and second members are circular
- 2 or rectangular.
- 1 44. The system of claim 1 wherein the electronics platform is mounted to a
- 2 recessed portion of the surface of the substrate, wherein the recessed portion and the
- 3 platform are within a cavity and wherein the platform is substantially equal in mass to the
- 4 removed cavity.
- 1 45. The process condition of claim 21 wherein in a first position the
- 2 electronics module is above or below the substrate, and in a second position the

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- electronics module and the substrate are displaced from each other such that the first and
- 4 second perimeter do not intersect.